

Notic of References CitedApplication/Control No
09/686 624Applicant(s)/Patent Under
Reexamination
LEE ET ALExaminer
Khiem D NguyenArt Unit
2823

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5 738 911	04-1998	Imamura et al	427/387
	B	US-5 974 666	11-1999	Tanaka et al.	29/895 32
	C	US-6 338 868	01-2002	Shibuya et al	427/10
	D	US-5 907 382	05-1999	Kajiura et al.	349/158
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	K	US-			
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